

# SN54HCT74, SN74HCT74 DUAL D-TYPE POSITIVE-EDGE-TRIGGERED FLIP-FLOPS WITH CLEAR AND PRESET

SCLS169B – DECEMBER 1982 – REVISED MAY 1997

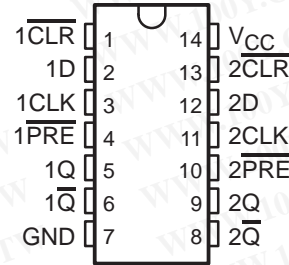
- Inputs Are TTL-Voltage Compatible
- Package Options Include Plastic Small-Outline (D), Thin Shrink Small-Outline (PW), and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

## description

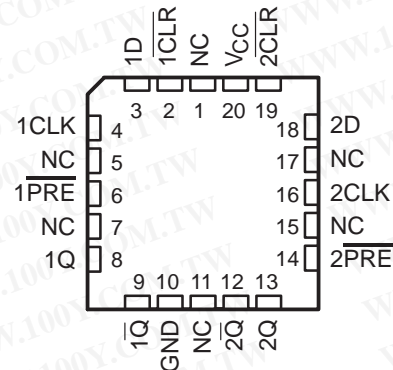
The 'HCT74 contain two independent D-type positive-edge-triggered flip-flops. A low level at the preset ( $\overline{\text{PRE}}$ ) or clear ( $\overline{\text{CLR}}$ ) inputs sets or resets the outputs regardless of the levels of the other inputs. When  $\overline{\text{PRE}}$  and  $\overline{\text{CLR}}$  are inactive (high), data at the data (D) input meeting the setup time requirements are transferred to the outputs on the positive-going edge of the clock (CLK) pulse. Clock triggering occurs at a voltage level and is not directly related to the rise time of CLK. Following the hold-time interval, data at the D input may be changed without affecting the levels at the outputs.

The SN54HCT74 is characterized for operation over the full military temperature range of  $-55^{\circ}\text{C}$  to  $125^{\circ}\text{C}$ . The SN74HCT74 is characterized for operation from  $-40^{\circ}\text{C}$  to  $85^{\circ}\text{C}$ .

SN54HCT74 . . . J OR W PACKAGE  
SN74HCT74 . . . D, N, OR PW PACKAGE  
(TOP VIEW)



SN54HCT74 . . . FK PACKAGE  
(TOP VIEW)



NC – No internal connection

FUNCTION TABLE

INPUTS				OUTPUT	
$\overline{\text{PRE}}$	$\overline{\text{CLR}}$	CLK	D	Q	$\overline{\text{Q}}$
L	H	X	X	H	L
H	L	X	X	L	H
L	L	X	X	H <sup>†</sup>	H <sup>†</sup>
H	H	↑	H	H	L
H	H	↑	L	L	H
H	H	L	X	Q <sub>0</sub>	Q <sub>0</sub>

<sup>†</sup>This configuration is unstable; that is, it does not persist when  $\overline{\text{PRE}}$  or  $\overline{\text{CLR}}$  returns to its inactive (high) level.

勝特力材料 886-3-5753170  
勝特力电子(上海) 86-21-54151736  
勝特力电子(深圳) 86-755-83298787  
[Http://www.100y.com.tw](http://www.100y.com.tw)



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 **TEXAS  
INSTRUMENTS**

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recommended operating conditions

		SN54HCT74			SN74HCT74			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V <sub>CC</sub>	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V <sub>IH</sub>	High-level input voltage	V <sub>CC</sub> = 4.5 V to 5.5 V			2			V
V <sub>IL</sub>	Low-level input voltage	V <sub>CC</sub> = 4.5 V to 5.5 V			0			V
V <sub>I</sub>	Input voltage	0			V <sub>CC</sub>			V
V <sub>O</sub>	Output voltage	0			V <sub>CC</sub>			V
t <sub>t</sub>	Input transition (rise and fall) time	0			500			ns
T <sub>A</sub>	Operating free-air temperature	-55			125			°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V <sub>CC</sub>	T <sub>A</sub> = 25°C			SN54HCT74		SN74HCT74		UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
V <sub>OH</sub>	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub>	4.5 V	I <sub>OH</sub> = -20 μA		4.4	4.499	4.4	4.4	V	
			I <sub>OH</sub> = -4 mA		3.98	4.3	3.7	3.84		
V <sub>OL</sub>	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub>	4.5 V	I <sub>OL</sub> = 20 μA		0.001	0.1	0.1	0.1	V	
			I <sub>OL</sub> = 4 mA		0.17	0.26	0.4	0.33		
I <sub>I</sub>	V <sub>I</sub> = V <sub>CC</sub> or 0	5.5 V	±0.1	±100	±1000	±1000	nA			
I <sub>CC</sub>	V <sub>I</sub> = V <sub>CC</sub> or 0, I <sub>O</sub> = 0	5.5 V	4		80	40	μA			
ΔI <sub>CC</sub> †	One input at 0.5 V or 2.4 V, Other inputs at 0 or V <sub>CC</sub>	5.5 V	1.4	2.4	3	2.9	mA			
C <sub>i</sub>		4.5 V to 5.5 V	3	10	10	10	pF			

† This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or V<sub>CC</sub>.

timing requirements over recommended operating free-air temperature range (unless otherwise noted)

		V <sub>CC</sub>	T <sub>A</sub> = 25°C		SN54HCT74		SN74HCT74		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	
f <sub>clock</sub>	Clock frequency	4.5 V	0	27	0	18	0	22	MHz
		5.5 V	0	30	0	20	0	24	
t <sub>w</sub>	Pulse duration	4.5 V	PRE or CLR low		24	20	ns		
			CLK high or low		18	23			
		5.5 V	PRE or CLR low		14	18			
			CLK high or low		16	21			
t <sub>su</sub>	Setup time before CLK↑	4.5 V	Data		12	15	ns		
			PRE or CLR inactive		11	14			
		5.5 V	Data		0	0			
			PRE or CLR inactive		0	0			
t <sub>h</sub>	Hold time, data after CLK↑	4.5 V	0		0	ns			
		5.5 V	0		0				

**SN54HCT74, SN74HCT74**  
**DUAL D-TYPE POSITIVE-EDGE-TRIGGERED FLIP-FLOPS**  
**WITH CLEAR AND PRESET**

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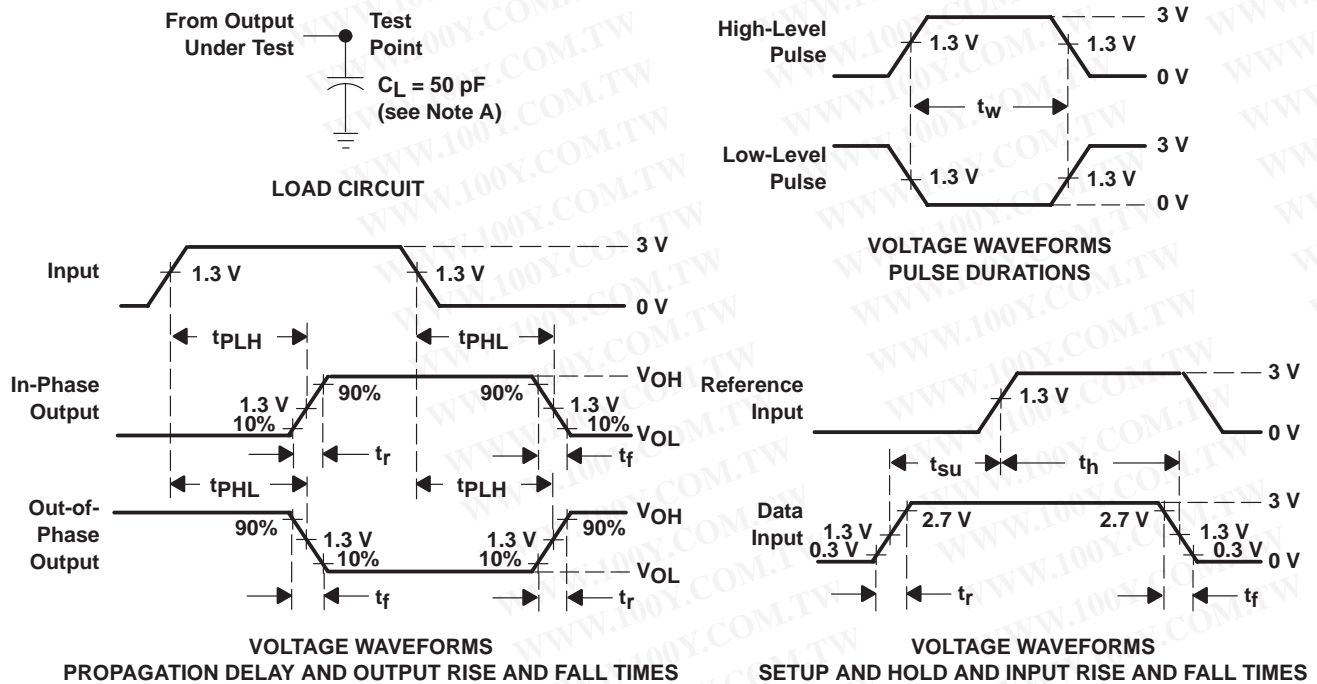
switching characteristics over recommended operating free-air temperature range,  $C_L = 50$  pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC}$	$T_A = 25^\circ\text{C}$			SN54HCT74		SN74HCT74		UNIT
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
$f_{\max}$			4.5 V	27	40		18		22	MHz	
			5.5 V	30	46		20		24		
$t_{pd}$	$\overline{\text{PRE}}$ or $\overline{\text{CLR}}$	Q or $\overline{\text{Q}}$	4.5 V		21	35		53		44	ns
			5.5 V		17	31		48		40	
	CLK	Q or $\overline{\text{Q}}$	4.5 V		20	28		42		35	
			5.5 V		18	25		38		31	
$t_t$		Q or $\overline{\text{Q}}$	4.5 V		8	15		22		19	ns
			5.5 V		7	14		20		17	

operating characteristics,  $T_A = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	TYP	UNIT
$C_{pd}$ Power dissipation capacitance per flip-flop	No load	35	pF

**PARAMETER MEASUREMENT INFORMATION**



- NOTES:
- A.  $C_L$  includes probe and test-fixture capacitance.
  - B. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics:  $PRR \leq 1$  MHz,  $Z_O = 50 \Omega$ ,  $t_r = 6$  ns,  $t_f = 6$  ns.
  - C. For clock inputs,  $f_{\max}$  is measured when the input duty cycle is 50%.
  - D. The outputs are measured one at a time with one input transition per measurement.
  - E.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .

**Figure 1. Load Circuit and Voltage Waveforms**

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